

BT138 series D and E

12 A four-quadrant triacs, sensitive gate
Rev. 02 — 12 March 2008

Product data sheet

Product profile

1.1 General description

Passivated sensitive gate triac in a SOT78 plastic package.

1.2 Features

- Very sensitive gate
- Direct interfacing to logic level ICs
- Gate triggering in four quadrants
- Direct interfacing to low power gate drive circuits

1.3 Applications

- General purpose switching and phase control
- 230 V lamp dimmers

1.4 Quick reference data

- $V_{DRM} \le 600 \text{ V (BT138-600D)}$
- V_{DRM} ≤ 600 V (BT138-600E)
- V_{DRM} ≤ 800 V (BT138-800E)
- $I_{GT} \le 5 \text{ mA (BT138-600D)}$
- $I_{GT} \le 10 \text{ mA (BT138-600E)}$
- $I_{GT} \le 10 \text{ mA (BT138-800E)}$
- $I_{T(RMS)} \le 12 A$
- $I_{TSM} \le 95 \text{ A (t = 20 ms)}$
- $I_{GT} \le 10 \text{ mA } (T2-G+) \text{ (BT138-600D)}$
- $I_{GT} \le 25 \text{ mA } (T2-G+) \text{ (BT138-600E)}$
- $I_{GT} \le 25 \text{ mA } (T2-G+) (BT138-800E)$



2. Pinning information

Table 1. Pinning

| Pin | Description | Simplified outline | Graphic symbol |
|-----|-------------------------------------|--------------------|----------------|
| 1 | main terminal 1 (T1) | | N.I. |
| 2 | main terminal 2 (T2) | mb | T2—T1 |
| 3 | gate (G) | | sym051 |
| mb | mounting base; main terminal 2 (T2) | 1 2 3 | |
| | | SOT78 (TO-220AB) | |

3. Ordering information

Table 2. Ordering information

| Type number | Package | Package | | | | |
|-------------|----------|---|---------|--|--|--|
| | Name | Description | Version | | | |
| BT138-600D | TO-220AB | plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead | | | | |
| BT138-600E | | TO-220AB | | | | |
| BT138-800E | | | | | | |

4. Limiting values

Table 3. Limiting values

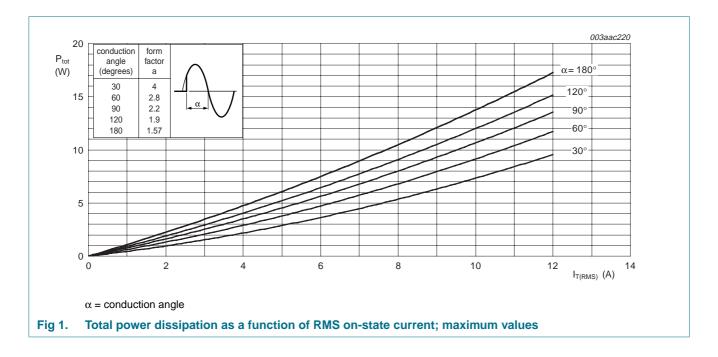
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|---------------------|--------------------------------------|---|--------------|-----|------------------|
| V_{DRM} | repetitive peak off-state voltage | | | | |
| | | BT138-600D | <u>[1]</u> _ | 600 | V |
| | | BT138-600E | <u>[1]</u> _ | 600 | V |
| | | BT138-800E | - | 800 | V |
| I _{T(RMS)} | RMS on-state current | full sine wave; $T_{mb} \le 99 ^{\circ}\text{C}$; see Figure 4 and 5 | - | 12 | Α |
| I _{TSM} | non-repetitive peak on-state current | full sine wave; $T_j = 25$ °C prior to surge; see Figure 2 and 3 | | | |
| | | t = 20 ms | - | 95 | Α |
| | | t = 16.7 ms | - | 105 | Α |
| l ² t | I ² t for fusing | t _p = 10 ms | - | 45 | A ² s |

Table 3. Limiting values ...continued
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|---|----------------------------------|--|-----|------|------|
| dl _T /dt rate of rise of on-state cu | rate of rise of on-state current | $I_{TM} = 20 \text{ A}; I_G = 0.2 \text{ A};$ $dI_G/dt = 0.2 \text{ A}/\mu\text{s}$ | | | |
| | | T2+ G+ | - | 50 | A/μs |
| | | T2+ G- | - | 50 | A/μs |
| | | T2- G- | - | 50 | A/μs |
| | | T2- G+ | - | 10 | A/μs |
| I _{GM} | peak gate current | | - | 2 | Α |
| P_{GM} | peak gate power | | - | 5 | W |
| $P_{G(AV)}$ | average gate power | over any 20 ms period | - | 0.5 | W |
| T _{stg} | storage temperature | | -40 | +150 | °C |
| Tj | junction temperature | | - | 125 | °C |

^[1] Although not recommended, off-state voltages up to 800 V may be applied without damage, but the triac may switch to the on-state. The rate of rise of current should not exceed 15 A/μ s.



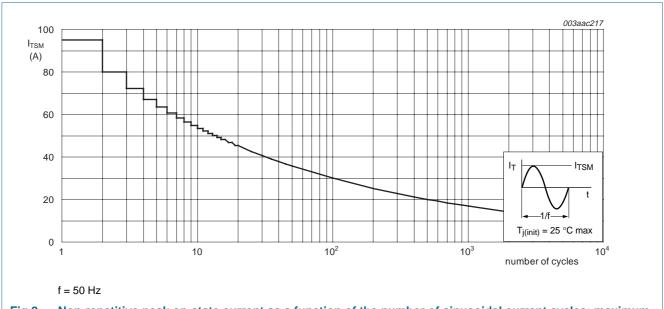
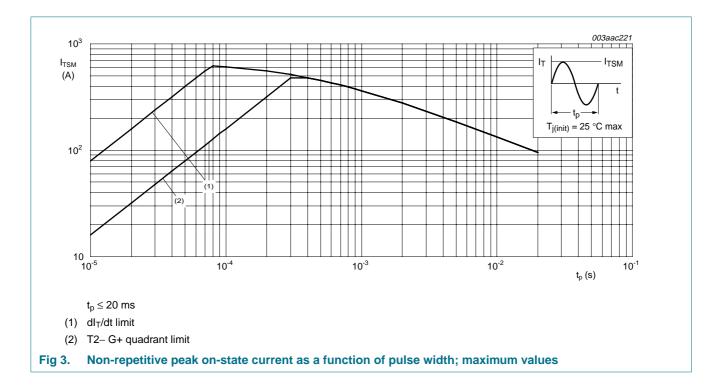


Fig 2. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values



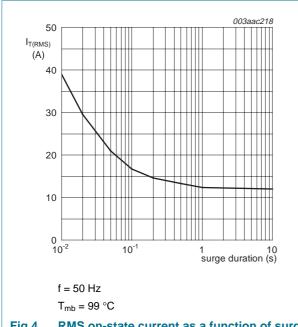


Fig 4. RMS on-state current as a function of surge duration; maximum values

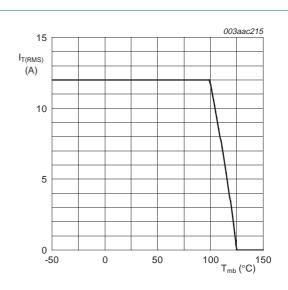
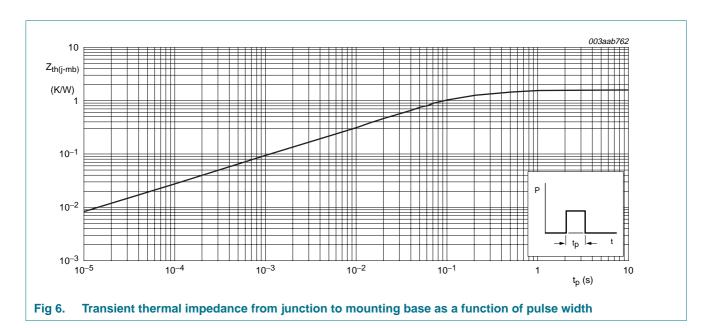


Fig 5. RMS on-state current as a function of mounting base temperature; maximum values

5. Thermal characteristics

Table 4. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------|---|--------------------------|-----|-----|-----|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | full cycle; see Figure 6 | - | - | 1.5 | K/W |
| $R_{th(j-a)}$ | thermal resistance from junction to ambient | full cycle; in free air | - | 60 | - | K/W |



6. Static characteristics

Table 5. Static characteristics

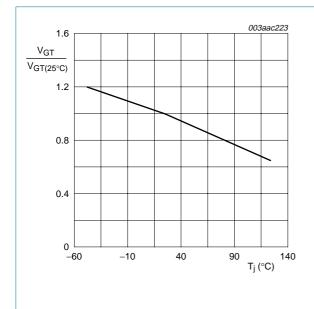
 $T_i = 25 \,^{\circ}C$ unless otherwise specified.

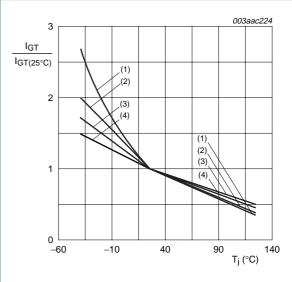
| Symbol | Parameter | Conditions | BT138 | BT138-600D | | | BT138-600E BT138-800E | | |
|--------------------------------------|----------------------|---|-------|------------|------|------|--------------------------|------|----|
| | | | Min | Тур | Max | Min | Тур | Max | |
| I _{GT} gate trigger current | | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A};$ see Figure 8 | | | ' | ' | ' | ' | ' |
| | | T2+ G+ | - | 1.3 | 5 | - | 2.5 | 10 | mΑ |
| | | T2+ G- | - | 2.8 | 5 | - | 4.0 | 10 | mΑ |
| | | T2- G- | - | 3.2 | 5 | - | 5.0 | 10 | mΑ |
| | | T2- G+ | - | 5.5 | 10 | - | 11 | 25 | mΑ |
| I _L latching current | | $V_D = 12 \text{ V}; I_G = 0.1 \text{ A};$ see Figure 10 | | | | | | | |
| | | T2+ G+ | - | - | 15 | - | - | 30 | mA |
| | | T2+ G- | - | - | 20 | - | - | 40 | mA |
| | | T2- G- | - | - | 15 | - | - | 30 | mA |
| | | T2- G+ | - | - | 20 | - | - | 40 | mA |
| I _H | holding current | $V_D = 12 \text{ V}; I_G = 0.1 \text{ A};$ see Figure 11 | - | - | 10 | - | - | 30 | mA |
| V_{T} | on-state voltage | I _T = 15 A; see Figure 9 | - | 1.4 | 1.65 | - | 1.4 | 1.65 | V |
| V_{GT} | gate trigger voltage | $I_T = 0.1 \text{ A}$; see Figure 7 | | | | | | | |
| | | V _D = 12 V; | - | 0.7 | 1.5 | - | 0.7 | 1.5 | V |
| | | $V_D = V_{DRM}$; $T_j = 125 ^{\circ}C$ | 0.25 | 0.4 | - | 0.25 | 0.4 | - | V |
| I _D | off-state current | $V_D = V_{DRM(max)};$ $T_j = 125 ^{\circ}C$ | - | 0.1 | 0.5 | - | 0.1 | 0.5 | mA |

7. Dynamic characteristics

Table 6. Dynamic characteristics

| Symbol Parameter | | Conditions | BT138-600D | | | BT138 | Unit | | |
|---------------------|-----------------------------------|---|------------|-----|-----|-------|------|-----|------|
| | | | Min | Тур | Max | Min | Тур | Max | |
| dV _D /dt | rate of rise of off-state voltage | $V_{DM} = 0.67 \times V_{DRM(max)};$ exponential waveform; gate open circuit; $T_j = 110 ^{\circ}C$ | - | 50 | - | - | 150 | - | V/μs |
| t _{gt} | gate-controlled turn-on time | $I_{TM} = 16 \text{ A};$ $V_D = V_{DRM(max)};$ $I_G = 0.1 \text{ A}; dI_G/dt = 5 \text{ A/}\mu\text{s}$ | - | 2 | - | - | 2 | - | μs |

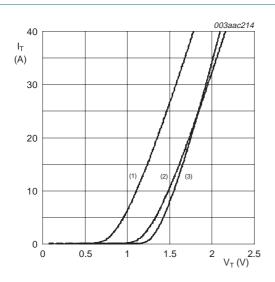




- (1) T2-G+
- (2) T2-G-
- (3) T2+ G-
- (4) T2+ G+

Fig 7. Normalized gate trigger voltage as a function of junction temperature

Fig 8. Normalized gate trigger current as a function of junction temperature



 $V_0 = 1.175 \text{ V}$

 $R_s = 0.032 \Omega$

(1) $T_i = 125$ °C; typical values

(2) $T_i = 125 \,^{\circ}C$; maximum values

(3) $T_j = 25$ °C; maximum values

Fig 9. On-state current as a function of on-state voltage

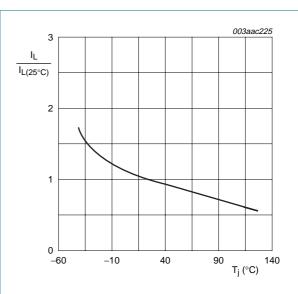


Fig 10. Normalized latching current as a function of junction temperature

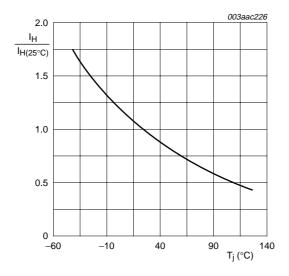


Fig 11. Normalized holding current as a function of junction temperature

8. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78

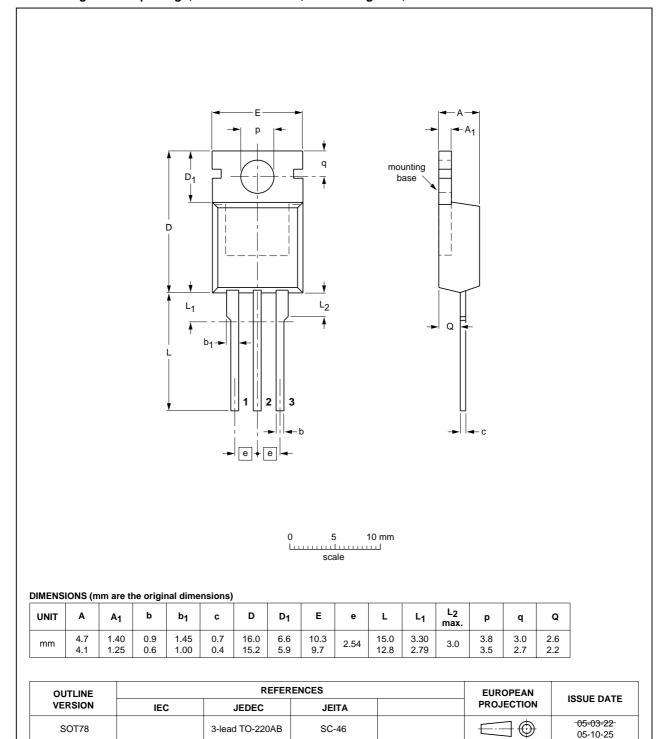


Fig 12. Package outline SOT78 (TO-220AB)

9. Revision history

Table 7. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes | | |
|------------------|---------------------------------|---|---------------------|------------------|--|--|
| BT138_SER_D_E_2 | 20080312 | Product data sheet | - | BT138_SERIES_E_1 | | |
| Modifications: | | The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. | | | | |
| | Legal texts | have been adapted to the n | ew company name whe | re appropriate. | | |
| | BT138-600I | O product added | | | | |
| BT138_SERIES_E_1 | 19970901 | Product data sheet | - | - | | |

BT138 series D and E

12 A four-quadrant triacs, sensitive gate

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| Document status[1][2] | Product status[3] | Definition |
|--------------------------------|-------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

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NXP Semiconductors

BT138 series D and E

12 A four-quadrant triacs, sensitive gate

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